Search Notes

| Application/Control No. | Applicant(s)/Patent Under Reexamination |
|-------------------------|---|
| 10585744 | BANDOH ET AL. |
| Examiner | Art Unit |
| SELIM AHMED | 2826 |

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| SEARCHED | | | | |
|----------|---------------------------------|------------|----------|--|
| Class | Subclass | Date | Examiner | |
| 257 | 101, 102, 103, e33.033, e33.034 | 5/4/2009 | /sa/ | |
| | Updated search | 11/13/2009 | /sa/ | |
| 257 | 79, 13 | 6/18/2010 | /sa/ | |
| 438 | 46, 47 | 6/18/2010 | /sa/ | |
| | Updated search | 6/18/2010 | /sa/ | |

| SEARCH NOTES | | | | |
|--|------------|----------|--|--|
| Search Notes | Date | Examiner | | |
| East Text search such as, Group III nitride, III-V nitride compound, GaN, n-type, layer/structure/film/region, high concentration, low concentration, Ge doped, pits/holes/recess, dislocation and their boolean combinations were searched. Please see attached search history. | 5/4/2009 | /sa/ | | |
| Updated search | 11/13/2009 | /sa/ | | |
| Updated search | 6/18/2010 | /sa/ | | |

| INTERFERENCE SEARCH | | | | |
|---------------------|----------|----------|-----------|----------|
| Class | | Subclass | Date | Examiner |
| 257 | 102, 103 | | 6/18/2010 | /sa/ |

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